

### 40V N-CHANNEL ENHANCEMENT MODE MOSFET

## **Product Summary**

BV <sub>DSS</sub>	R <sub>DS(ON)</sub> Max	I <sub>D</sub> Max T <sub>A</sub> = +25°C
40V	$9.5$ m $\Omega$ @ V <sub>GS</sub> = 10V	11.8A
40 V	15.5mΩ @ $V_{GS} = 4.5V$	9.2A

### **Description**

This MOSFET is designed to minimize the on-state resistance (R<sub>DS(ON)</sub>), yet maintain superior switching performance, making it ideal for high efficiency power management applications.

## **Applications**

- **Power Management Functions**
- **DC-DC Converters**
- Backlighting

### **Features**

- Low R<sub>DS(ON)</sub> Ensures on state losses are minimized
- Excellent Qgd x RDS(ON) Product (FOM)
- 0.6mm Profile Ideal for Low Profile Applications
- PCB Footprint of 4mm<sup>2</sup>
- Low Gate Threshold Voltage
- Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

### **Mechanical Data**

- Case: U-DFN2020-6 (Type F)
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020

D

D

G

1

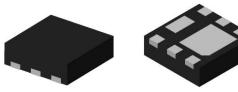
- Terminals: Finish NiPdAu over Copper Leadframe. Solderable per MIL-STD-202, Method 208 @4
- Weight: 0.0065 grams (Approximate)

### U-DFN2020-6 (Type F)

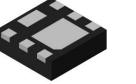
6 D

S

5 D



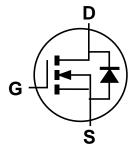
Top View



**Bottom View** 

Pin Out **Bottom View** 

D



Internal Schematic

## Ordering Information (Note 4)

Part Number	Case	Quantity per Reel
DMT4008LFDF-7	U-DFN2020-6 (Type F)	3,000
DMT4008LFDF-13	U-DFN2020-6 (Type F)	10,000

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.
- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

## Marking Information



8M = Product Type Marking Code YM = Date Code Marking

Y = Year (ex: F = 2018)

M = Month (ex: 9 = September)

Date Code Key

Year	2016	3	2017	2018	3	2019	2020	)	2021	2022		2023
Code	D		Е	F		G	Н		I	J		K
Month	Jan	Feb	Mar	Apr	Ma	y Jun	Jul	Aug	g Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



# **Maximum Ratings** (@ $T_A = +25$ °C, unless otherwise specified.)

Characteristic	Symbol	Value	Unit
Drain-Source Voltage	V <sub>DSS</sub>	40	V
Gate-Source Voltage	V <sub>GSS</sub>	±20	V
Continuous Drain Current (Note 6) V <sub>GS</sub> = 10V	I <sub>D</sub>	11.8 9.4	А
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)	I <sub>DM</sub>	70	Α
Pulsed Body Diode Forward Current (10µs Pulse, Duty Cycle = 1%)	I <sub>SM</sub>	70	А
Continuous Source-Drain Diode Current	Is	2.2	А
Avalanche Current, L = 0.3mH	I <sub>AS</sub>	13.3	Α
Avalanche Energy, L = 0.3mH	E <sub>AS</sub>	26.5	mJ

## **Thermal Characteristics**

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	T <sub>A</sub> = +25°C	$P_{D}$	0.8	W
Thermal Resistance, Junction to Ambient (Note 5)		$R_{\theta JA}$	155	°C/W
Total Power Dissipation (Note 6)	T <sub>A</sub> = +25°C	P <sub>D</sub>	2.0	W
Thermal Resistance, Junction to Ambient (Note 6)		$R_{\theta JA}$	63	°C/W
Thermal Resistance, Junction to Case (Note 6)	T <sub>C</sub> = +25°C	R <sub>0JC</sub>	8.9	°C/W
Operating and Storage Temperature Range		$T_{J}, T_{STG}$	-55 to +150	°C

# Electrical Characteristics (@T<sub>A</sub> = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)						•	
Drain-Source Breakdown Voltage	BV <sub>DSS</sub>	40	l	_	V	$V_{GS} = 0V, I_D = 250\mu A$	
Zero Gate Voltage Drain Current (T <sub>J</sub> = +25°C)	I <sub>DSS</sub>	_		1	μΑ	$V_{DS} = 32V, V_{GS} = 0V$	
Gate-Source Leakage	I <sub>GSS</sub>		_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	V <sub>GS(TH)</sub>	1	1.7	3	V	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
Static Drain-Source On-Resistance	RDS(ON)	_	7.8	9.5	mΩ	V <sub>GS</sub> = 10V, I <sub>D</sub> = 10A	
Static Dialit-Source On-Resistance	KD2(ON)	_	10.6	15.5	11177	$V_{GS} = 4.5V, I_D = 8.5A$	
Diode Forward Voltage	$V_{SD}$	_	0.7	1.0	V	$V_{GS} = 0V, I_{S} = 10A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C <sub>iss</sub>	_	1179	_			
Output Capacitance	Coss	_	384	_	pF	$V_{DS} = 20V, V_{GS} = 0V,$ f = 1MHz	
Reverse Transfer Capacitance	C <sub>rss</sub>	_	42			I = TIVII IZ	
Gate Resistance	R <sub>G</sub>	_	1.7	_	Ω	$V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$	
Total Gate Charge (V <sub>GS</sub> = 4.5V)	$Q_G$	_	8.3	_			
Total Gate Charge (V <sub>GS</sub> = 10V)	$Q_{G}$	_	17.1	_	nC	), 00\/ L 10A	
Gate-Source Charge	Q <sub>GS</sub>	_	2.4	_	nc	$V_{DD} = 20V, I_D = 10A$	
Gate-Drain Charge	$Q_{GD}$	_	3.4	_			
Turn-On Delay Time	t <sub>D(ON)</sub>	_	3.5	_			
Turn-On Rise Time	t <sub>R</sub>	_	3.7	_		$V_{DD} = 20V, V_{GS} = 10V,$	
Turn-Off Delay Time	t <sub>D(OFF)</sub>	_	17.1	_	ns	$R_G = 6\Omega$ , $I_D = 10A$	
Turn-Off Fall Time	t <sub>F</sub>	_	6.4	_			
Reverse Recovery Time	t <sub>RR</sub>	_	19.8	_	ns	400 31/31 4000/105	
Reverse Recovery Charge	$Q_{RR}$	_	8.8	_	nC	$I_F = 10A$ , di/dt = 100A/ $\mu$ s	

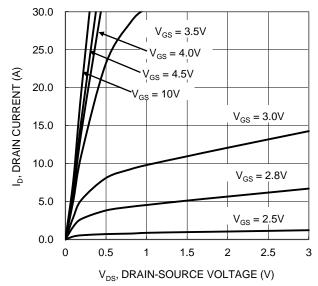
5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

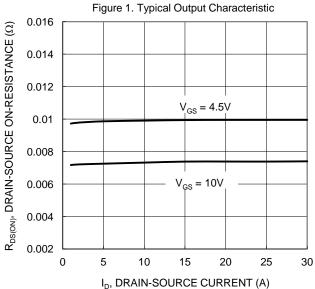
<sup>6.</sup> Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.
7. Short duration pulse test used to minimize self-heating effect.

<sup>8.</sup> Guaranteed by design. Not subject to product testing.









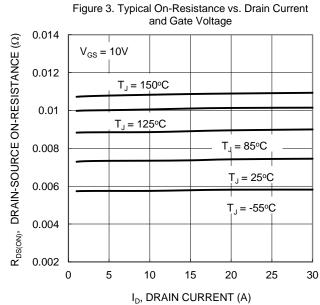
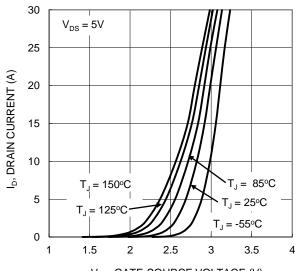


Figure 5. Typical On-Resistance vs. Drain Current and Junction Temperature



V<sub>GS</sub>, GATE-SOURCE VOLTAGE (V) Figure 2. Typical Transfer Characteristic

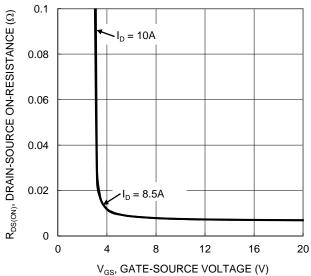
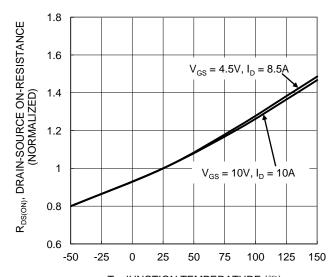


Figure 4. Typical Transfer Characteristic



 $T_{\rm J}$ , JUNCTION TEMPERATURE ( $^{\circ}$ C) Figure 6.On-Resistance Variation with Junction Temperature





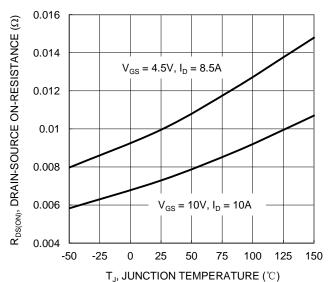
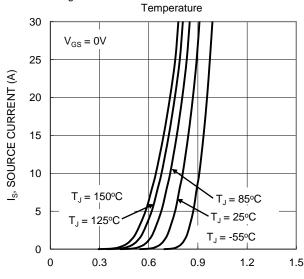


Figure 7. On-Resistance Variation with Junction
Temperature



V<sub>SD</sub>, SOURCE-DRAIN VOLTAGE (V) Figure 9. Diode Forward Voltage vs. Current

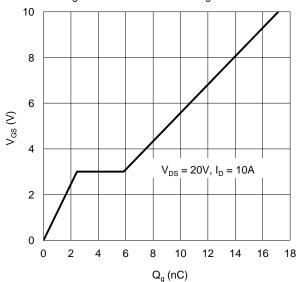


Figure 11. Gate Charge

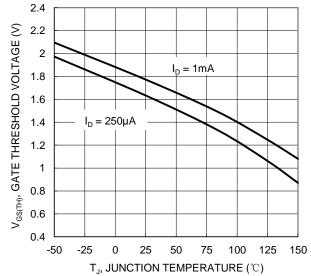
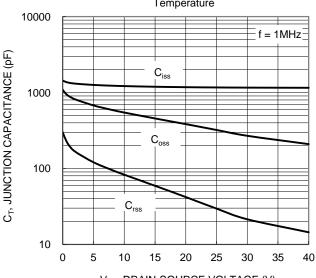


Figure 8. Gate Threshold Variation vs. Junction Temperature



V<sub>DS</sub>, DRAIN-SOURCE VOLTAGE (V) Figure 10. Typical Junction Capacitance

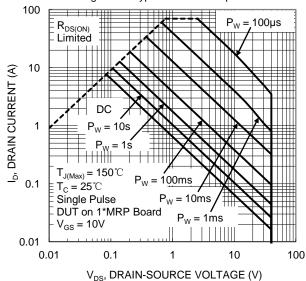


Figure 12. SOA, Safe Operation Area



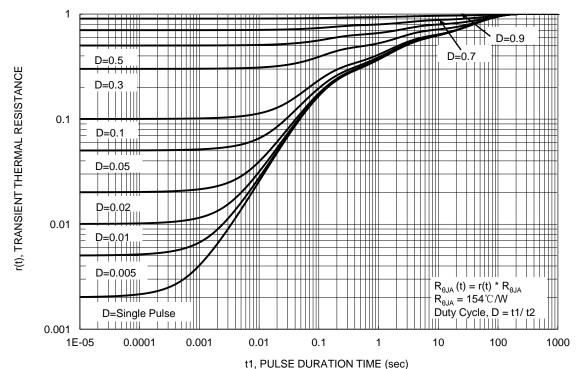


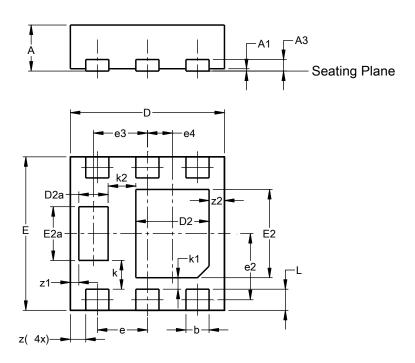
Figure 13. Transient Thermal Resistance



# **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### U-DFN2020-6 (Type F)

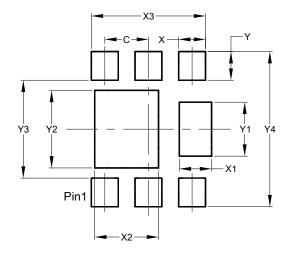


U-DFN2020-6									
(Type F)									
Dim	Min Max Typ								
Α	0.57 0.63 0.60								
A1	0.00 0.05 0.03								
А3	-	-	0.15						
b	0.25	0.35	0.30						
D	1.95	2.05	2.00						
D2	0.85	1.05	0.95						
D2a	0.33	0.43	0.38						
Е	1.95	2.05	2.00						
E2	1.05 1.25 1.15								
E2a	0.65 0.75 0.70								
е	0.65 BSC								
e2	C	0.863 BSC							
е3		0.70 BS	С						
e4	(	).325 BS	SC						
k	0.37 BSC								
k1	0.15 BSC								
k2	0.36 BSC								
L	0.225 0.325 0.275								
Z	0.20 BSC								
z1	0.110 BSC								
z2	0.20 BSC								
All Dimensions in mm									

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### U-DFN2020-6 (Type F)



Dimensions	Value		
Dilliensions	(in mm)		
С	0.650		
Х	0.400		
X1	0.480		
X2	0.950		
Х3	1.700		
Y	0.425		
Y1	0.800		
Y2	1.150		
Y3	1.450		
Y4	2.300		



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